



30V Complementary MOSFET

General Description

The AO4606 uses advanced trench technology MOSFETs to provide excellent $R_{\text{DS}(\text{ON})}$ and low gate charge. The complementary MOSFETs may be used to form a level shifted high side switch, and for a host of other applications.

Product Summary

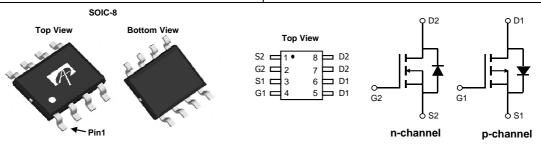
 I_{D} = 6A (V_{GS} =10V) -6.5A (V_{GS} =-10V)

 $\mathsf{R}_{\mathsf{DS}(\mathsf{ON})} \qquad \qquad \mathsf{R}_{\mathsf{DS}(\mathsf{ON})}$

 $< 30 m\Omega \ (V_{GS} = 10 V) \\ < 42 m\Omega \ (V_{GS} = 4.5 V) \\ < 44 m\Omega \ (V_{GS} = 4.5 V)$

100% UIS Tested 100% UIS Tested 100% R_g Tested 100% R_g Tested





Absolute Maximum	Ratings	T _A =25℃ unless	otherwise noted

Parameter		Symbol	Max n-channel	Max p-channel	Units	
Drain-Source Voltage		V_{DS}	30	-30	V	
Gate-Source Voltage		V_{GS}	±20	±20	V	
Continuous Drain	T _A =25℃	I_	6	-6.5		
Current	T _A =70℃	'D	5	-5.3	Α	
Pulsed Drain Current ^Ċ		I _{DM}	30	-30		
Avalanche Current ^C		I _{AS} , I _{AR}	10	23	Α	
Avalanche energy L=	0.1mH ^C	E _{AS} , E _{AR}	5	26	mJ	
	T _A =25℃	P _D	2	2	W	
Power Dissipation ^B	T _A =70℃	l D	1.3	1.3	v v	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150		C	

Thermal Characteristics							
Parameter		Symbol	Тур	Max	Units		
Maximum Junction-to-Ambient ^A	t ≤ 10s	D	48	62.5	℃/W		
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	74	90	℃/W		
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	32	40	C/W		



N-Channel Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units	
STATIC PARAMETERS								
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	I _D =250μA, V _{GS} =0V				V	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =30V, V _{GS} =0V				1	μΑ	
idss	Zero Gate Voltage Drain Current					5		
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V	•			±100	nA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$		1.2	1.8	2.4	V	
$I_{D(ON)}$	On state drain current	V_{GS} =10V, V_{DS} =5V		30			Α	
		V_{GS} =10V, I_D =6A			25	30	mΩ	
R _{DS(ON)}	Static Drain-Source On-Resistance		T _J =125℃		40	48	11122	
		V_{GS} =4.5V, I_D =5A			33.5	42	mΩ	
g _{FS}	Forward Transconductance	$V_{DS}=5V$, $I_{D}=6A$			15		S	
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.76	1	V	
Is	Maximum Body-Diode Continuous Cur	rent				2.5	Α	
DYNAMIC	PARAMETERS							
C _{iss}	Input Capacitance			200	255	310	pF	
Coss	Output Capacitance	V _{GS} =0V, V _{DS} =15V, f=	V_{GS} =0V, V_{DS} =15V, f=1MHz		45	60	рF	
C _{rss}	Reverse Transfer Capacitance]		20	35	50	pF	
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		1.6	3.25	4.9	Ω	
SWITCHI	NG PARAMETERS							
Q _g (10V)	Total Gate Charge		V _{GS} =10V, V _{DS} =15V, I _D =6A		5.2	6	nC	
Q _g (4.5V)	Total Gate Charge	\/10\/_\/15\/_I			2.55	3	nC	
Q_{gs}	Gate Source Charge	VGS=10V, VDS=13V, 1			0.85		nC	
Q_{gd}	Gate Drain Charge				1.3		nC	
t _{D(on)}	Turn-On DelayTime				4.5		ns	
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_{L} =2.5 Ω ,			2.5		ns	
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$	$R_{GEN}=3\Omega$		14.5		ns	
t _f	Turn-Off Fall Time]			3.5		ns	
t _{rr}	Body Diode Reverse Recovery Time	I _F =6A, dI/dt=100A/μs			8.5	12	ns	
Q_{rr}	Body Diode Reverse Recovery Charge	e I _F =6A, dI/dt=100A/μs	-		2.2	3	nC	

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The A. The value in any given application depends on the user's specific board design. B. The power dissipation P_D is based on $T_{J(MAX)}=150^\circ$ C, using $\le 10s$ junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=150^\circ$ C. Ratings are based on low frequency and duty cycles to keep

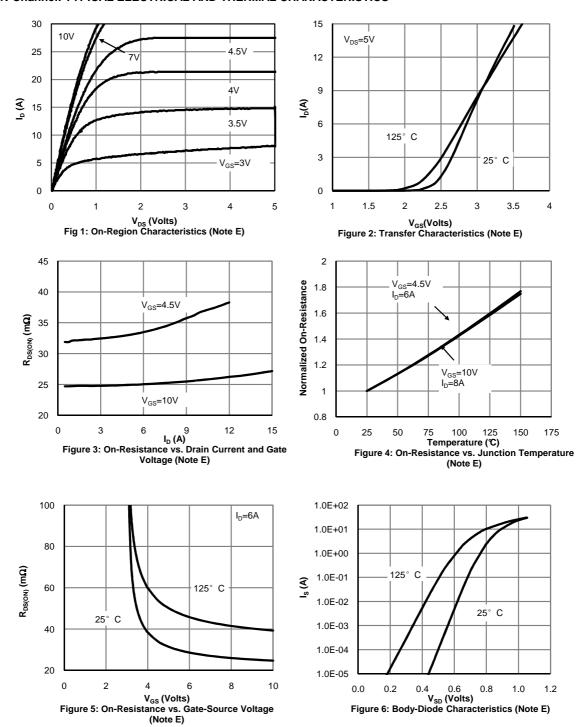
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initialT_J=25° C.

D. The R_{0JA} is the sum of the thermal impedence from junction to lead R_{0JL} and lead to ambient. E. The static characteristics in Figures 1 to 6 are obtained using <300 μ s pulses, duty cycle 0.5% max. F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.



N-Channel: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



1000

10

100



0.0001

0.0001

0.001

N-Channel: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

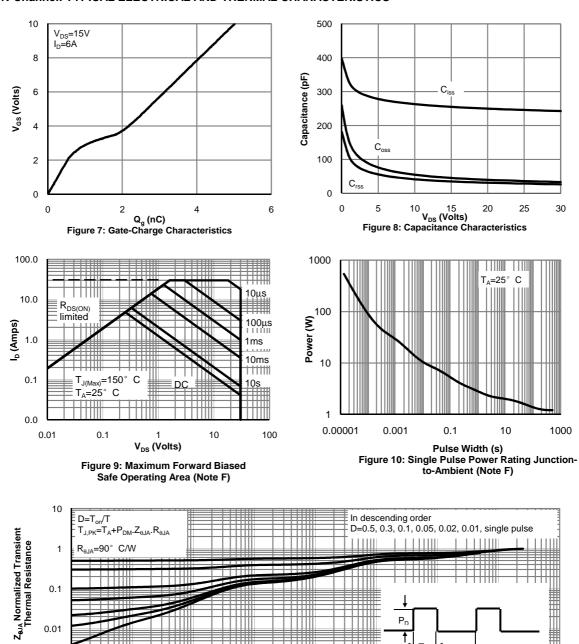
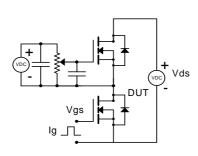


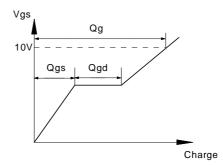
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

0.01 0.1 Pulse Width (s)

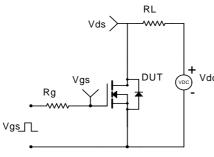


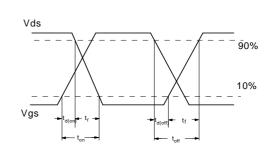
Gate Charge Test Circuit & Waveform



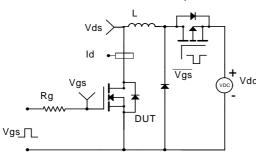


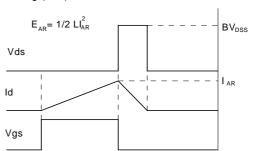
Resistive Switching Test Circuit & Waveforms



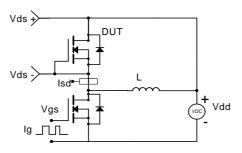


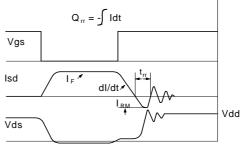
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms







P-Channel Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units		
STATIC PARAMETERS								
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-30			V		
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =-30V, V_{GS} =0V			-1			
DSS	Zero Gate Voltage Drain Current	T _J =55℃			-5	μΑ		
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V			±100	nA		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=-250\mu A$	-1.3	-1.85	-2.4	V		
I _{D(ON)}	On state drain current	V_{GS} =-10V, V_{DS} =-5V	-30			Α		
		V_{GS} =-10V, I_D =-6.5A		22	28	mΩ		
$R_{DS(ON)}$	Static Drain-Source On-Resistance	T _J =125℃		32	40	11152		
		V_{GS} =-4.5V, I_D =-5A		34	44	mΩ		
g _{FS}	Forward Transconductance	V_{DS} =-5V, I_D =-6.5A		18		S		
V_{SD}	Diode Forward Voltage	I _S =-1A,V _{GS} =0V		-0.8	-1	V		
Is	Maximum Body-Diode Continuous Current				-2.5	Α		
DYNAMIC	PARAMETERS							
C _{iss}	Input Capacitance			760		pF		
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =-15V, f=1MHz		140		pF		
C _{rss}	Reverse Transfer Capacitance			95		pF		
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz	1.5	3.2	5	Ω		
SWITCHI	NG PARAMETERS							
Q _g (10V)	Total Gate Charge			13.6	16	nC		
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =-15V, I _D =-6.5A		6.7	8	nC		
Q_{gs}	Gate Source Charge	- VGS-10V, VDS-13V, ID-0.3A		2.5		nC		
Q_{gd}	Gate Drain Charge			3.2		nC		
t _{D(on)}	Turn-On DelayTime			8		ns		
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =-15V, R_L =2.3 Ω ,		6		ns		
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$		17		ns		
t _f	Turn-Off Fall Time			5		ns		
t _{rr}	Body Diode Reverse Recovery Time	I _F =-6.5A, dI/dt=100A/μs		15		ns		
Q_{rr}	Body Diode Reverse Recovery Charge	_F I _F =-6.5A, dI/dt=100A/μs		9.7		nC		

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The A. The value in any given application depends on the user's specific board design. B. The power dissipation P_D is based on $T_{J(MAX)}=150^\circ$ C, using $\le 10s$ junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=150^\circ$ C. Ratings are based on low frequency and duty cycles to keep

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initialT_{.l}=25° C.

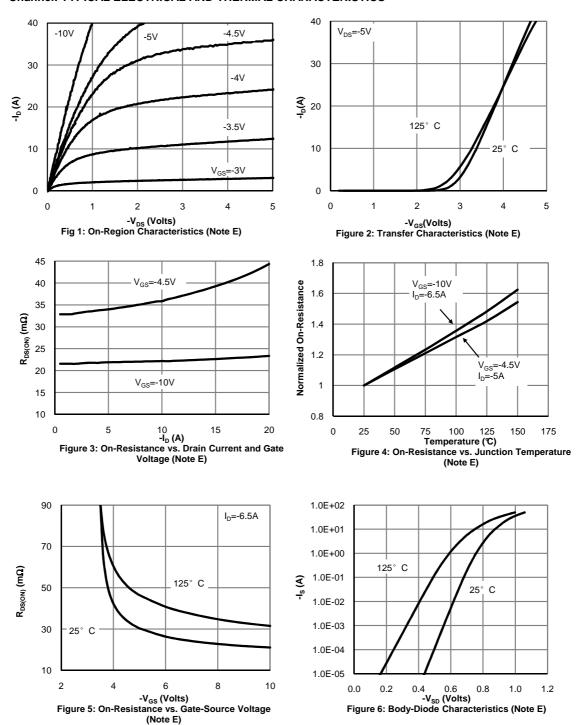
D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.



P-Channel: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





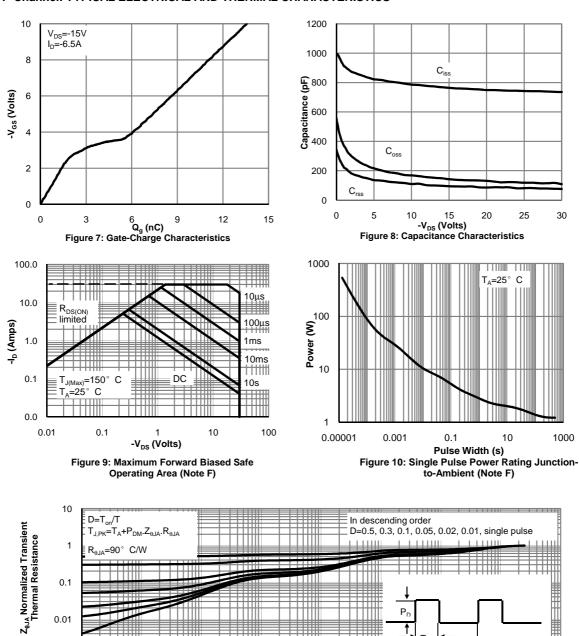
0.01

0.001 0.00001

0.0001

0.001

P-Channel: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

0.1

0.01

 P_{D}

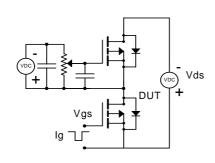
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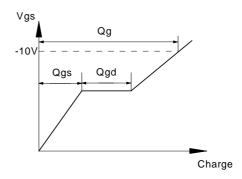
100

1000

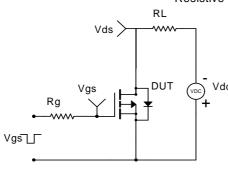


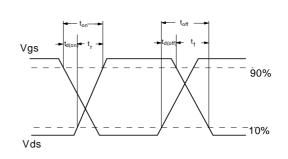
Gate Charge Test Circuit & Waveform



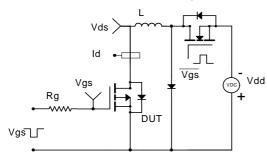


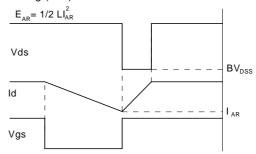
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

